

23NM50N-VB TO263 Datasheet

N-Channel 650 V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	650				
R _{DS(on)} (Ω) at 25 °C	$V_{GS} = 10 V$	0.19			
Q _g max. (nC)	106				
Q _{gs} (nC)	14				
Q _{gd} (nC)	33				
Configuration	Single				

FEATURES

- Reduced t_{rr}, Q_{rr}, and I_{RRM}
- Low figure-of-merit (FOM) Ron x Qq
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q_{rr}
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Consumer and computing
- ATX power supplies
- Industrial
 - Welding
 - Battery chargers
- Renewable energy
 - Solar (PV inverters)
- Switch mode power supplies (SMPS)

ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \degree C$, unless otherwise noted)									
PARAMETER			SYMBOL	LIMIT	UNIT				
Drain-Source Voltage		V _{DS}	650	V					
Gate-Source Voltage			V _{GS}	± 30	v				
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	- I _D -	20					
	VGS AL TO V	T _C = 100 °C		13	А				
Pulsed Drain Current ^a		I _{DM}	60						
Linear Derating Factor			1.7	W/°C					
Single Pulse Avalanche Energy ^b		E _{AS}	367	mJ					
Maximum Power Dissipation			PD	208	W				
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C					
Drain-Source Voltage Slope	T _J = 125 °C		dV/dt	37	V/ns				
Reverse Diode dV/dt ^d		av/dt	31	v/ns					
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C				

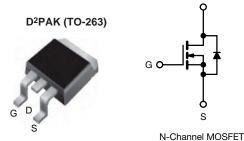
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 5.1 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.

HALOGEN FREE



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PARAMETER	SYMBOL	TYP.		MAX.	UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-		62				
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.5	°C/W			
	1100							
SPECIFICATIONS (T _J = 25 °C, u	Inless otherwi	ise noted)						
PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT	
Static	I.					1		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	V _{GS} = 0 V, I _D = 250 μA		-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 1$ mA		-	0.67	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$		2	-	4	V	
		$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA	
Gate-Source Leakage	I _{GSS}			-	-	± 1	μA	
Zero Gate Voltage Drain Current	1	V _{DS} =	= 520 V, V _{GS} = 0 V	-	-	1	μA	
	IDSS	V _{DS} = 520 V	/, V _{GS} = 0 V, T _J = 125	°C -	-	500		
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 11 A	-	0.19	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D = 11 A	-	7.0	-	S	
Dynamic				•				
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ $f = 1 MHz$ $V_{DS} = 0 V \text{ to } 520 V, V_{GS} = 0 V$		-	2322	-	pF	
Output Capacitance	C _{oss}			-	105	-		
Reverse Transfer Capacitance	C _{rss}			-	4	-		
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	84	-		
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	293	-		
Total Gate Charge	Qg	V _{GS} = 10 V I _D = 11 A, V _{DS} = 520 V		-	71	106	nC	
Gate-Source Charge	Q _{gs}			20 V -	14	-		
Gate-Drain Charge	Q _{gd}			-	33	-		
Turn-On Delay Time	t _{d(on)}			-	22	44	ns	
Rise Time	t _r	V _{DD} =	V _{DD} = 520 V, I _D = 11 A,		34	68		
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 10 V, R_g = 9.1 Ω		-	68	102		
Fall Time	t _f			-	42	84		
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characteristi	cs							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	21	A	
Pulsed Diode Forward Current	I _{SM}			s -	-	53		
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V		V -	0.9	1.2	V	
Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 11 \text{ A},$ dI/dt = 100 A/ μ s, V _R = 25 V		-	160	-	ns	
Reverse Recovery Charge	Q _{rr}			-	1.2	-	μC	
Reverse Recovery Current	I _{RRM}			_	14	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

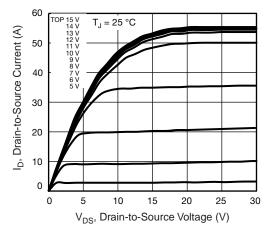


Fig. 1 - Typical Output Characteristics



Fig. 2 - Typical Output Characteristics

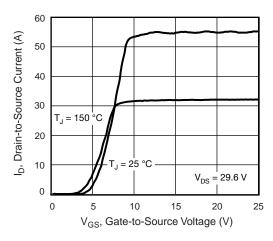


Fig. 3 - Typical Transfer Characteristics

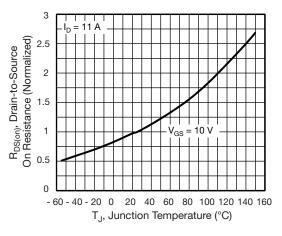


Fig. 4 - Normalized On-Resistance vs. Temperature

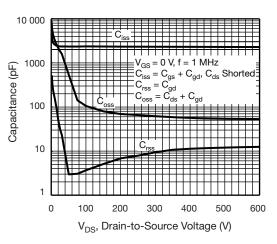


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}

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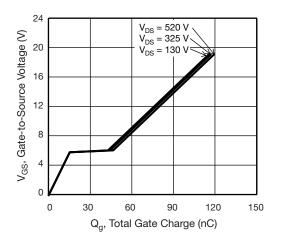


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

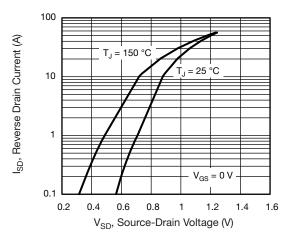


Fig. 8 - Typical Source-Drain Diode Forward Voltage

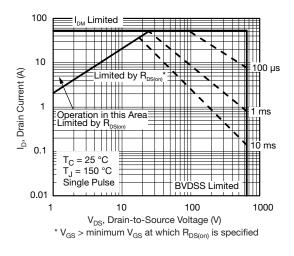


Fig. 9 - Maximum Safe Operating Area

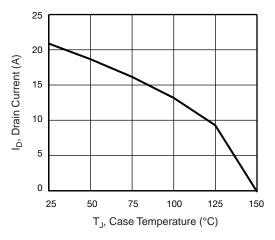


Fig. 10 - Maximum Drain Current vs. Case Temperature

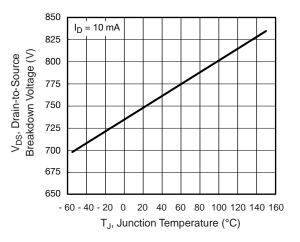


Fig. 11 - Temperature vs. Drain-to-Source Voltage



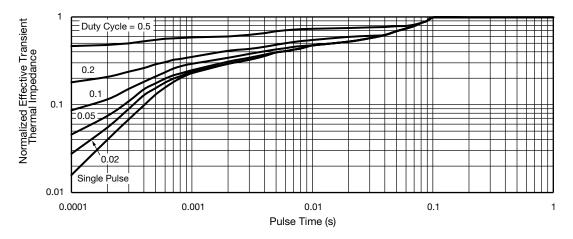


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case



Fig. 13 - Switching Time Test Circuit



Fig. 14 - Switching Time Waveforms

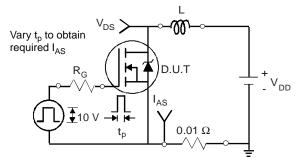


Fig. 15 - Unclamped Inductive Test Circuit

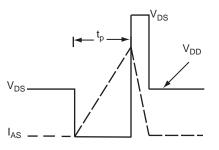


Fig. 16 - Unclamped Inductive Waveforms

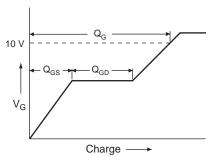
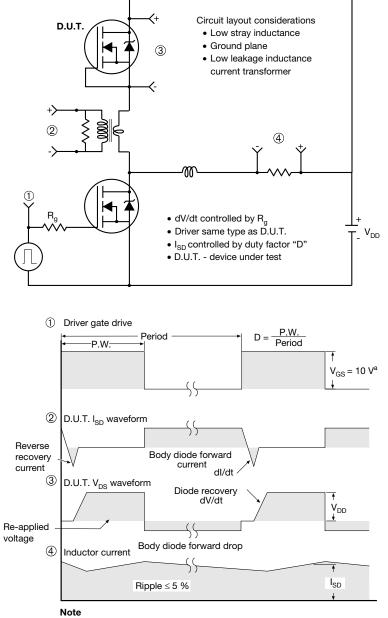


Fig. 17 - Basic Gate Charge Waveform





Peak Diode Recovery dV/dt Test Circuit

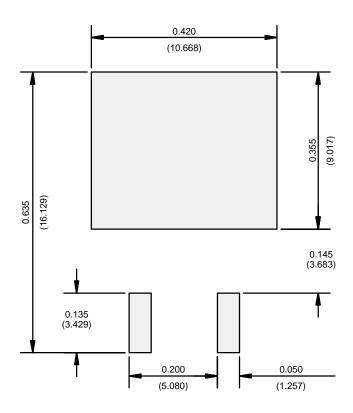


a. $V_{GS} = 5$ V for logic level devices

Fig. 19 - For N-Channel



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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